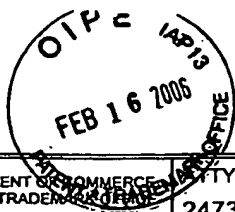


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 247321US3CONT		SERIAL NO. 10/757,439	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Kazuhisa SUDO, et al.			
				RCE FILED January 13, 2006		GROUP 2852	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
45	AF	2004-046268	2/2004	JAPAN (w/abstract)			
44	AG	09-166912	6/1997	JAPAN (w/abstract)			
45	AH	64-17550	1/1989	JAPAN		X	
45	AI	2001-175083	6/2001	JAPAN (w/abstract)			
45	AJ	1-24739	1/1986	JAPAN		X	
45	AK	11-272075	10/1999	JAPAN (w/abstract)			
45	AL	10-063087	3/1998	JAPAN (w/abstract)			
45	AM	04-143781	5/1992	JAPAN (w/abstract)			
45	AN	58-123444	8/1983	JAPAN		X	
45	AO	10-293452	11/1998	JAPAN (w/abstract)			
45	AP	04-134471	5/1992	JAPAN (w/abstract)			
45	AQ	09-022175	1/1997	JAPAN (w/abstract)			
45	AR	10-097130	4/1998	JAPAN (w/abstract)			
45	AS	09-292773	11/1997	JAPAN (w/abstract)			
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner <i>Tom Tan</i>					Date Considered 05/14/06		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Form PTO 1449  
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PATENT AND TRADEMARK OFFICE

PRIORITY DOCKET NO.

247321US3CONT

SERIAL NO.

10/757,439

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Kazuhisa SUDO, et al.

FILING DATE

RCE Filed January 13, 2006

GROUP

2852

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
HT	AO	2000-227706	8/15/2000	Japan (with Abstract)		X
HT	AP	60-3856	1/12/1985	Japan	X	
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

*Tom Tan*

Date Considered

01/14/06

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



SHEET 1 OF 1

Form PTO 1449  
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PATENT AND TRADEMARK OFFICEATTY DOCKET NO.  
247321US3CONTSERIAL NO.  
10/757,439

## LIST OF REFERENCES CITED BY APPLICANT

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2852

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HS	AA	5,740,507	4/14/98	Ichikawa et al.			
HS	AB	5,655,195	8/5/97	Ichikawa et al.			
HS	AC	5,950,055	9/7/99	Yahata et al.			
HS	AD	5,915,154	6/22/99	Schoch et al.			
HS	AE	5,570,170	10/29/96	Muranyi et al.			
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HS	AG	4,945,956	8/7/90	Bueyuekgueclue et al.			
HS	AH	4,503,625	3/12/85	Manzer			
HS	AI	5,848,326	12/8/98	Komuro et al.			

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
HS	AJ	JP 2000-128192	May-2000	JAPAN (w/abstract)		X
HS	AK	EP 1,014,214	Jun-2005	EUROPEAN		
HS	AL	EP 1,193,570	Nov-2004	EUROPEAN		
HS	AM	JP 08-211723	Aug-1996	JAPAN (w/abstract)		X
HS	AN	JP 03-241372	Oct-1991	JAPAN (w/abstract)		X
HS	AO	JP 08-292636	Nov-1996	JAPAN (w/abstract)		X
HS	AP	JP 02-053055	Feb-1990	JAPAN (w/abstract)		X
HS	AQ	JP 08-314272	Nov-1996	JAPAN (w/abstract)		X
HS	AR	JP 04-087901	Mar-1992	JAPAN (w/abstract)		X
HS	AS	JP 09-106156	Apr-1997	JAPAN (w/abstract)		X
HS	AT	JP 61-059464	Mar-1986	JAPAN (w/abstract)		X
HS	AU	JP 64-052181	Feb-1989	JAPAN (w/abstract)		X
HS	AV	JP 08-171281	Jul-1996	JAPAN (w/abstract)		X
HS	AW	JP 05-232810	Sep-1993	JAPAN (w/abstract)		X
HS	AX	JP 57-057451	Apr-1982	JAPAN (w/abstract)		X
HS	AY	JP 06-208301	Jul-1994	JAPAN (w/abstract)		X
HS	AZ	JP 07-261529	Oct-1995	JAPAN (w/abstract)		X
HS	AAA	JP 06-191049	Jul-1994	JAPAN (w/abstract)		X
HS	AAB	JP 09-305080	Nov-1997	JAPAN (w/abstract)		X
HS	AAC	JP 06-059572	Mar-1994	JAPAN (w/abstract)		X

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

		<input type="checkbox"/> Additional References sheet(s) attached
Examiner	<i>Tom Tan</i>	Date Considered <i>02/14/06</i>

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.